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Attorney's Docket No.: 15682-017US1 / OSP-19442

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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: Nobuo Imamura et al.

Art Unit : Unknown

Examiner: Unknown

Serial No. :

: January 31, 2006

Filed Title

: CHIP REMOVAL METHOD AND CHIP REMOVAL AIR BLOW NOZZLE

P.O. Box 1450

Alexandria, VA 22313-1450

Commissioner for Patents

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed and enclosed on the attached PTO-1449 form. English-language translations are attached for Desig. IDs AL-AO. A copy of an International Search Report (ISR) is also enclosed. The relevance of Desig. IDs AP-AS is indicated in the ISR.

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date:	1/31/06	Lune Forodace
		Samuel Borodach
		Reg. No. 38,388

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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 15682-017US1

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Information Disclosure Statement by Applicant

(Use several sheets if necessary)

Applicant Nobuo Imamura et al.

Filing Date

Group Art Unit

(37 CFR §1.98(b))

January 31, 2006

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB	<u> </u>					
	AC						
	AD						
	AE		,				
	AF						
	AG						
	AH						
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or				slation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	2002-096034	04/02/2002	Japan			X	
,	AM	06-190625	07/12/1994	Japan			х	
	AN	09-085573	03/31/1997	Japan			X	
	AO	05-16078	03/02/1993	Japan			X	
	AP	51-122479	10/04/1976	Japan				X
	AQ	62-246455	10/27/1987	Japan				X
	AR	2-15244	01/30/1990	Japan				X
	AS	62-138546	09/01/1987	Japan				X

Other Documents (include Author, Title, Date, and Place of Publication)				
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Initial	ID	Document		
	AT			
	AU			

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Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.